

# MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

80 V, 6.5 m $\Omega$  , 48 A

# **FDMC86340**

# Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWETRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

#### **Features**

- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)} = 6.5 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 14 \text{ A}$
- Max  $R_{DS(on)} = 8.5 \text{ m}\Omega$  at  $V_{GS} = 8 \text{ V}$ ,  $I_D = 12 \text{ A}$
- High Performance Technology for Extremely Low R<sub>DS(on)</sub>
- Termination is Lead-Free
- RoHS Compliant

# **Applications**

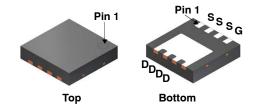
• DC-DC Conversion

#### MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise specified)

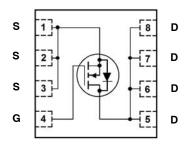
Symbol	Parameter	Ratings	Unit
V <sub>DS</sub>	Drain-to-Source Voltage	80	V
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
I <sub>D</sub>	Drain Current – Continuous $T_C = 25^{\circ}C$ $T_A = 25^{\circ}C$ (Note 1a)	48 14	Α
	- Pulsed (Note 4)	200	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)	216	mJ
P <sub>D</sub>	Power Dissipation $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C \text{ (Note 1a)}$	54 2.3	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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WDFN8 CASE 483AW



#### **MARKING DIAGRAM**

\$YZXYYKK FDMC 86340

\$Y = onsemi Logo
Z = Assembly Plant Code
XYY = Date Code (Year &Week)
KK = Lot Traceability Code
FDMC86340 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
FDMC86340	WDFN8 (Pb-Free, Halide Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	2.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	53	

# **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS			•	•	
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	80	_	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	46	_	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V	-	_	1	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	±100	nA
N CHARAC	CTERISTICS					
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \mu A$	2.0	3.4	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate-to-Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	-10	-	mV/°C
R <sub>DS(on)</sub>	R <sub>DS(on)</sub> Static Drain-to-Source	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14 A	-	5.0	6.5	mΩ
On Resistance	V <sub>GS</sub> = 8 V, I <sub>D</sub> = 12 A	-	6.0	8.5		
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14 A, T <sub>J</sub> = 125°C	-	8.5	11	
9FS	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 14 A	-	36	-	S
YNAMIC C	HARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	2775	3885	pF
C <sub>oss</sub>	Output Capacitance		_	468	655	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		_	15	25	pF
$R_g$	Gate Resistance		0.1	0.7	2.1	Ω
WITCHING	CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, I_D = 14 \text{ A}, V_{GS} = 10 \text{ V},$	-	20	32	ns
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$	_	7.9	16	
t <sub>d(off)</sub>	Turn-Off Delay Time		_	23	37	
t <sub>f</sub>	Fall Time		_	5.1	10	
Q <sub>g(tot)</sub>	Total Gate Charge	$V_{GS}$ = 0 V to 10 V, $V_{DD}$ = 40 V, $I_D$ = 14 A	-	38	53	nC
Q <sub>g(tot)</sub>	Total Gate Charge	$V_{GS}$ = 0 V to 8 V, $V_{DD}$ = 40 V, $I_D$ = 14 A	-	31	44	
Q <sub>gs</sub>	Gate-to-Source Charge	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 14 A	-	14	-	
Q <sub>gd</sub>	Gate-to-Drain "Miller" Charge	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 14 A	-	8.0	-	
Q <sub>oss</sub>	Output Charge	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 0 V	-	42	-	1

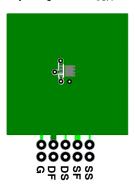
# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
DRAIN-SOU	DRAIN-SOURCE DIODE CHARACTERISTICS					
$V_{SD}$	Source-to-Drain Diode Forward	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 14 A (Note 2)	-	0.80	1.3	V
	Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2)	_	0.7	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 14 A, di/dt = 100 A/μs	_	41	66	ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	25	40	nC

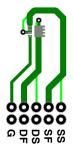
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5  $\times$  1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%. 3. E<sub>AS</sub> of 216 mJ is based on starting T<sub>J</sub> = 25 °C, L = 3 mH, I<sub>AS</sub> = 12 A, V<sub>DD</sub> = 80 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 37 A. 4. Pulsed Id limited by junction temperature, td  $\leq$  100  $\mu$ S, please refer to SOA curve for more details.

# **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25°C unless otherwise noted)

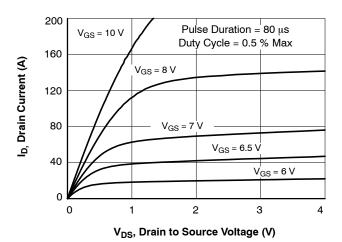


Figure 1. On-Region Characteristics

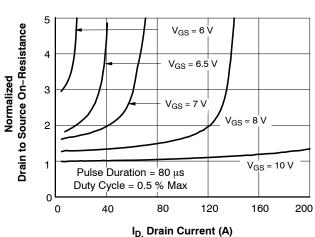


Figure 2. Normalized On-Resistance vs.

Drain Current and Gate Voltage

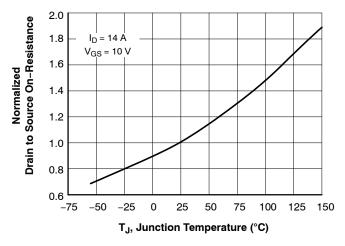


Figure 3. Normalized On–Resistance vs. Junction Temperature

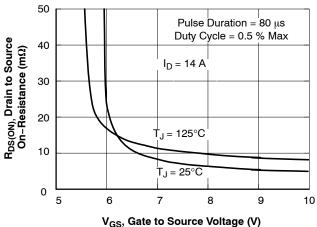


Figure 4. On-Resistance vs.

Gate to Source Voltage

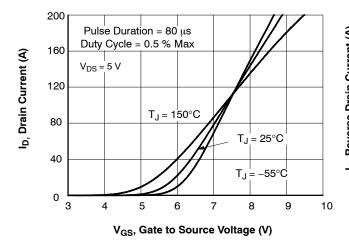
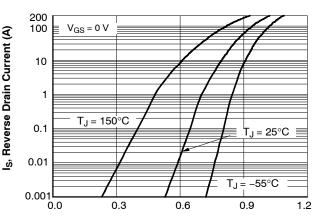


Figure 5. Transfer Characteristics



V<sub>SD</sub>, Body Diode Forward Voltage (V)

Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

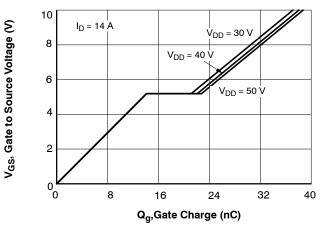


Figure 7. Gate Charge Characteristics

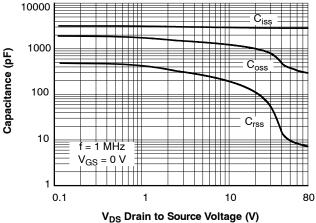


Figure 8. Capacitance vs Drain to Source Voltage

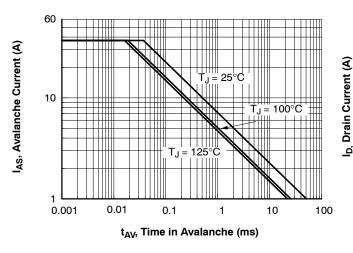


Figure 9. Unclamped Inductive Switching Capability

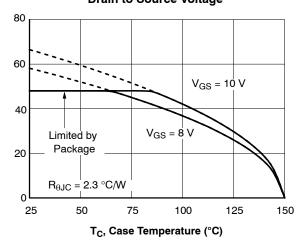


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

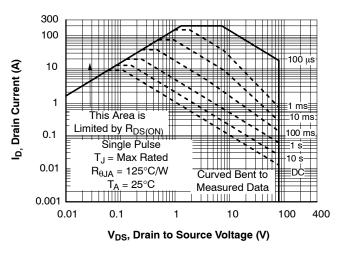


Figure 11. Forward Bias Safe Operating Area

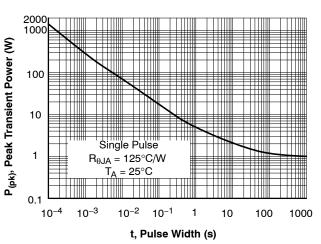


Figure 12. Single Pulse Maximum Power Dissipation

# TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

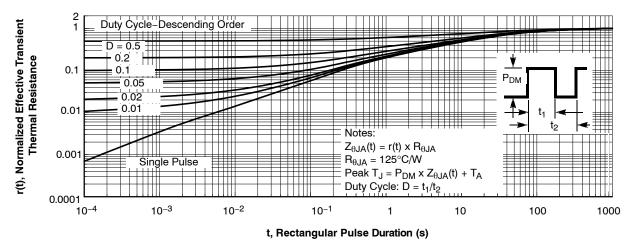


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

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Α

5

TOP VIEW

В



TERMINAL #1

INDEX AREA

(D/2 X E/2)

☐ aaa C

## WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

**DATE 22 MAR 2024** 

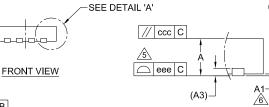
#### NOTES:

C

SEATING

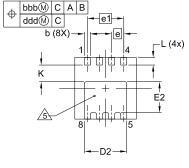
**PLANE** 

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



aaa C

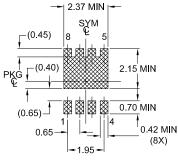
2X



**BOTTOM VIEW** 

LAND PATTERN RECOMMENDATION

DETAIL A



\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS			
Diivi	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1			0.05	
А3		0.20 REF	=	
b	0.27	0.32	0.37	
D	;	3.30 BSC	;	
D2	2.17	2.27	2.37	
Е	3.30 BSC			
E2	1.56	1.66	1.76	
е	(	0.65 BSC		
e1		1.95 BSC	;	
K	0.90			
L	0.30	0.40	0.50	
aaa	0.10			
bbb	0.10			
ccc	0.10			
ddd	0.05			
eee	0.05			

MILLIMETERS

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1	

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